Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/628,457	ONO ET AL.		
Examiner	Art Unit		

James W. Cranson

SEARCHED					
Subclass	Date	Examiner			
24	4/23/2005	wc			
29	4/23/2005	JWC			
313-317	4/23/2005	JWC			
22	4/23/2005	JWC			
30	4/23/2005	JWC			
	24 29 313-317 22 30	Subclass Date 24 4/23/2005 29 4/23/2005 313-317 4/23/2005 22 4/23/2005 30 4/23/2005			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
362\$.CCLS.		4/23/2005	JWC
200/\$.CCLS.		4/23/2005	JWC
341/\$.CCLS.	:	4/23/2005	JWC
			

2875